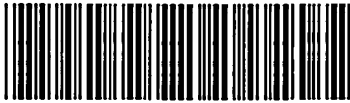


**Search Notes**

Application/Control No.

10/773,315

Examiner

Hai L. Nguyen

Applicant(s)/Patent under  
Reexamination

KURODA ET AL.

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner
327	154-156, 160-163, 261, 269-273	3/24/2005	HLN
↓	276-279	↓	↓
↓	284-286	↓	↓
375	354-360	3/25/2005	↓
713	400	↓	↓
365	233,233.5	↓	↓

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Minh Nguyen, primary examiner A.U. 2816	3/24/2005	HLN
Shepardize Search	3/25/2005	HLN